## Notice of References Cited Application/Control No. O9/966,613 Applicant(s)/Patent Under Reexamination SAGAR, RIK Examiner Fadey S. Jabr Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0149576 a1	08-2003	Sunyich, Steven L.	705/1
	В	US-2003/0109938 A1	06-2003	Daum et al.	700/11
	С	US-4,899,373	02-1990	Lee et al.	379/201.05
	D	US-6,834,208 B2	12-2004	Gonzales et al.	700/86
	Е	US-2003/0023463 A1	01-2003	Dombroski et al.	705/5
	F	US-2002/0073183	06-2002	Yoon et al.	709/220
	G	US-			
	н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s			,		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	v	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.